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Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
	24345	"713"/\$.ccls.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/03/01 14:06
L2	12590	"712"/\$.ccls.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/03/01 14:07
L3	2	I1 and ((((rate adj4 change)with ((pending or wait\$4)adj instruction\$1)))with (instruction adj (buffer or register)))	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/03/01 14:11
L4	0	I2 and ((((rate adj4 change)with ((pending or wait\$4)adj instruction\$1)))with (instruction adj (buffer or register)))	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/03/01 14:11
L5	111	I2 and ((instruction ad) (buffer or register))near3 full\$4)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/03/01 14:10
L6	5	I1 and ((instruction adj (buffer or register))near3 full\$4)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/03/01 14:10
L7	2	l6 and ((((rate adj4 change)with ((pending or wait\$4)adj instruction\$1)))with (instruction adj (buffer or register)))	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/03/01 14:11
L8	0	I5 and ((((rate adj4 change)with ((pending or wait\$4)adj instruction\$1)))with (instruction adj (buffer or register)))	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/03/01 14:11



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